

Highly Accurate Analysis of Magnetic Field by Local-Expansion Edge Element Method with Boundary Surface Integration

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The Local-expansion Edge Element Method (LEEM) enables us to analyze magnetic field more accurately than the ordinary finite element method (FEM). This paper proposes the combination of LEEM and Boundary Surface Integration (BSI) as a post-processing for computational accuracy enhancement. In the proposed method, we also investigate an appropriate virtual boundary configuration for BSI in local-expansion region and achieve highly accurate analysis.

Index Terms— local-expansion element, edge element, boundary surface integration, post-processing, magnetic field analysis.

I. INTRODUCTION

The Local-expansion Edge Element Method (LEEM), which is based on the local expansion theory known as the general solution of Laplace's equation, enables us to interpolate physical quantities in a target domain with higher order functions and perform highly accurate magnetic field analysis [1]. In this paper, we propose the combination of LEEM and Boundary Surface Integration (BSI) as a post-processing to make further enhancement of computational accuracy for magnetic shield problems, etc. By using BSI, we can accurately calculate magnetic field as smooth and continuous physical quantity. We also investigate the influence of virtual boundary configuration in local-expansion region on the computational accuracy.

II. FORMULATION

A. Local-expansion Edge Element Method

Fig. 1 shows the conceptual diagram of the proposed method. Fig. 2 shows the local-expansion element, e.g., a quadrangular pyramid, in which the vector potential \mathbf{A} is expressed as the following equation by using \mathbf{A} defined on each edge [1]-[4].

$$\mathbf{A} = \sum_{n=2}^N \left[\sum_{e=1}^4 \phi_n(t) \{f_e(r, s) \nabla r + g_e(r, s) \nabla s\} A_{e,n}^{rs} + \sum_{e=5}^8 \frac{d\phi_n(t)}{dt} h_e(r, s) \nabla t A_{e,n}^t \right], \quad (1)$$

$$\phi_n(t) = t^n \quad (n = 2, 3, \dots, N), \quad (2)$$

where N is order of expansion, f_e, g_e, h_e are scalar shape functions defined by TABLE I and ϕ_n is expansion function. The unknown variables ($A_{e,n}^{rs}, A_{e,n}^t$) are assigned on each edge of the LE, where the subscript e_n represents the edge number of e with the expansion order of n . In this paper, instead of using (2), the orthogonalized expansion function is used to improve convergence characteristic of LEEM [1].

TABLE I
EXPRESSION OF f_e, g_e AND h_e

e	$f_e(r, s)$	$g_e(r, s)$	e	$h_e(r, s)$
1	$(1-s)/4$	0	5	$(1-s)(1-r)/4$
2	$(1+s)/4$	0	6	$(1-s)(1+r)/4$
3	0	$(1-r)/4$	7	$(1+s)(1+r)/4$
4	0	$(1+r)/4$	8	$(1+s)(1-r)/4$

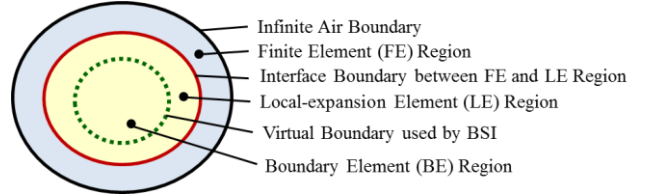


Fig. 1. Conceptual diagram of application of BSI to LEEM.

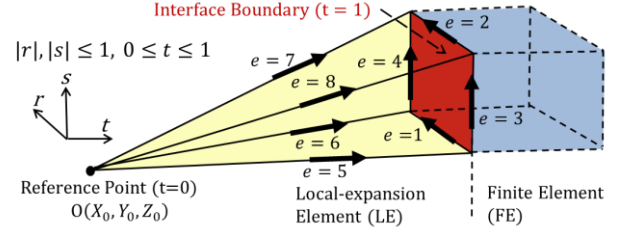


Fig. 2. Definition of local-expansion element.

B. Application of Boundary Surface Integration in Post-processing

After carrying out the magnetic field analysis by LEEM, we set a virtual boundary surrounding the target domain inside the LE region as shown in Fig. 1. The boundary integral equation with magnetic scalar potential φ is given as [5]

$$\frac{\Omega}{4\pi} \varphi(\mathbf{r}') = \frac{1}{4\pi} \int_S \left\{ \frac{\mathbf{n}}{|\mathbf{r} - \mathbf{r}'|} \frac{\partial \varphi}{\partial n}(\mathbf{r}) - \frac{\mathbf{r} - \mathbf{r}'}{|\mathbf{r} - \mathbf{r}'|^3} \varphi(\mathbf{r}) \right\} \cdot d\mathbf{S}, \quad (3)$$

where Ω is the solid angle subtended by the target domain at the investigated point. $\partial\varphi/\partial n$ on the virtual boundary is directly given by LEEM. φ on the virtual boundary can be derived by solving a linear system made by (3) with $\partial\varphi/\partial n$. Then, we can accurately obtain \mathbf{B} at arbitrary points in the target domain as smooth and continuous physical quantity by calculating the negative gradient of (3).

